

Welcome to the new era of RF Test and Measurement!

To our valued customers:

Thank you for choosing OPTEOS' patented Electro-Optic Field-Mapping service. We understand that accurate, speedy, and comprehensive characterization of your RF devices – whether they are highly integrated circuits or large-scale antenna arrays – is extremely important for the success of your business in today's highly competitive environment. Now you can experience a new, previously unexplored world of RF characterization. OPTEOS invites you to look inside your RF devices and see all the detailed electrical phenomena within your valuable creations.

OPTEOS' success will only be measured by your success. From the moment you choose OPTEOS' RF characterization service, OPTEOS shares exactly the same goal that you have – your success. Our commitment is not limited to providing technical support to your projects and products. Rather, we wish to be your partner throughout your journey to success.

Welcome to OPTEOS, Inc.



Sincerely,

A handwritten signature in blue ink, appearing to read "Kyoung Yang".

Kyoung Yang
President